STFI5N95K3



N-channel 950 V, 3 Ω typ., 4 A Zener-protected SuperMESH3™ Power MOSFET in I²PAKFP package

Datasheet - production data

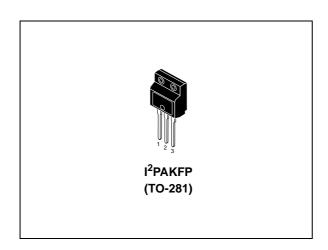
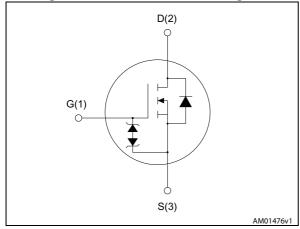


Figure 1. Internal schematic diagram



Features

Order code	V_{DS}	R _{DS(on)} max	I _D	P _{TOT}
STFI5N95K3	950 V	$3.5~\Omega$	4 A	25 W

- Fully insulated and low profile package with increased creepage path from pin to heatsink plate
- 100% avalanche tested
- Extremely large avalanche performance
- Gate charge minimized
- Very low intrinsic capacitances
- Zener-protected

Applications

· Switching applications

Description

This SuperMESH3™ Power MOSFET is the result of improvements applied to STMicroelectronics' SuperMESH™ technology, combined with a new optimized vertical structure. This device boasts an extremely low onresistance, superior dynamic performance and high avalanche capability, rendering it suitable for the most demanding applications.

Table 1. Device summary

Order code	Marking	Package	Packaging
STFI5N95K3	5N95K3	I ² PAKFP (TO-281)	Tube

Contents STFI5N95K3

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STFI5N95K3 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate- source voltage	±30	V
I _D	Drain current (continuous) at T _C = 25 °C	4 ⁽¹⁾	А
I _D	Drain current (continuous) at T _C = 100 °C	3 ⁽¹⁾	A
I _{DM} ⁽²⁾	Drain current (pulsed)	16 ⁽¹⁾	А
P _{TOT}	Total dissipation at T _C = 25 °C	25	W
I _{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _J max)	4	А
E _{AS}	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	100	mJ
dv/dt ⁽³⁾	Peak diode recovery voltage slope	5	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s,T _C = 25 °C)	2500	V
T _J Operating junction temperature T _{stg} Storage temperature		-55 to 150	°C

^{1.} Limited by maximum junction temperature

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case} Thermal resistance junction-case max		5	°C/W
R _{thj-amb} Thermal resistance junction-ambient max		62.5	°C/W

^{2.} Pulse width limited by safe operating area

^{3.} $I_{SD} \leq 4 \text{ A, di/dt} \leq 100 \text{ A/}\mu\text{s, peak } V_{DS} \leq V_{(BR)DSS}$

Electrical characteristics STFI5N95K3

2 Electrical characteristics

(Tcase =25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	950			٧
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 950 V V _{DS} = 950 V, T _C =125 °C			1 50	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 2 A		3	3.5	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	460	-	pF
C _{oss}	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$	-	38	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	1	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	$V_{DS} = 0$ to 760 V, $V_{GS} = 0$	-	970	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	V _{DS} = 0 to 760 V, V _{GS} = 0	1	15	1	pF
R _g	Gate input resistance	f=1 MHz open drain	-	5.5	-	Ω
Qg	Total gate charge	V _{DD} = 760 V, I _D = 4 A, V _{GS} = 10 V	-	19	-	nC
Q_{gs}	Gate-source charge		-	4.7	-	nC
Q_{gd}	Gate-drain charge	(see Figure 16)	-	12	-	nC

^{1.} Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

^{2.} Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table	6.	Switc	hing	times
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 475 \text{ V}, I_{D} = 2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 15)	-	17	-	ns
t _r	Rise time		-	7	-	ns
t _{d(off)}	Turn-off delay time		-	32	-	ns
t _f	Fall time		-	18	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		4	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		16	Α
V _{SD} (2)	Forward on voltage	I _{SD} = 4 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 4 A, di/dt = 100 A/μs	-	410		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V (see Figure 17)	-	3.5		μC
I _{RRM}	Reverse recovery current		-	17		Α
t _{rr}	Reverse recovery time	I _{SD} = 4 A, di/dt = 100 A/µs V _{DD} = 60 V T _J = 150 °C	-	516		ns
Q _{rr}	Reverse recovery charge		-	4.1		μC
I _{RRM}	Reverse recovery current	(see Figure 17)	-	16		Α

- 1. Pulse width limited by safe operating area
- 2. Pulsed: pulse duration = $300 \mu s$, duty cycle 1.5%

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	I_{GS} = ± 1 mA, I_{D} =0	30	-	-	٧

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

Electrical characteristics STFI5N95K3

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

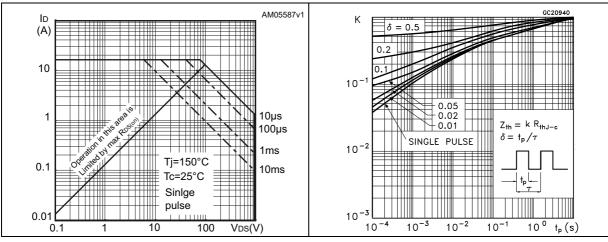


Figure 4. Output characteristics

Figure 5. Transfer characteristics

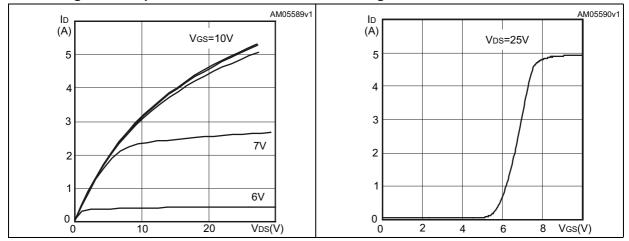


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance

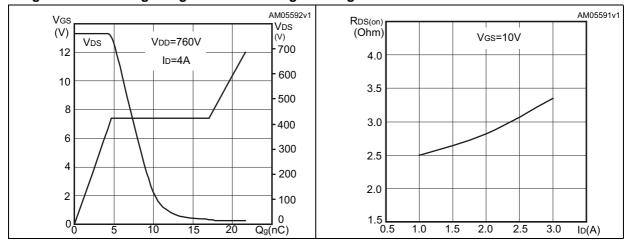


Figure 8. Capacitance variations

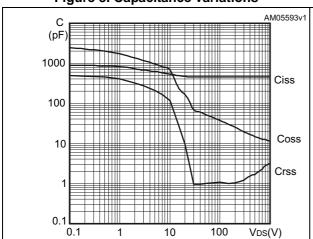


Figure 9. Output capacitance stored energy

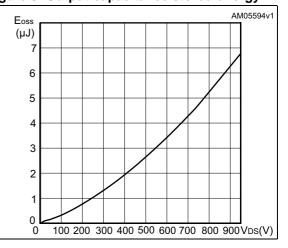
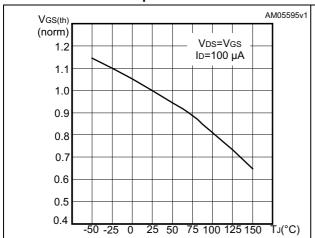


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on-resistance vs temperature



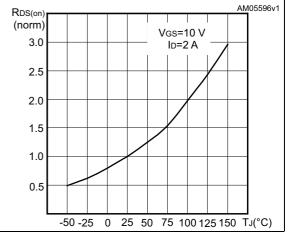
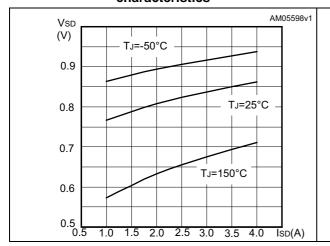
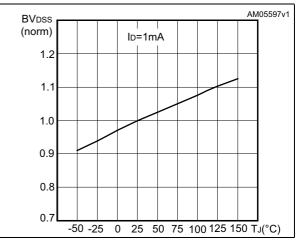


Figure 12. Source-drain diode forward characteristics

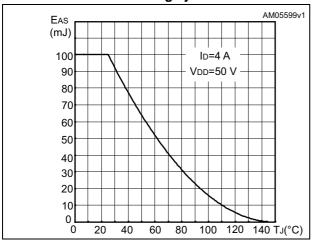
Figure 13. Normalized B_{VDSS} vs temperature





Electrical characteristics STFI5N95K3

Figure 14. Maximum avalanche energy vs starting Tj



STFI5N95K3 Test circuits

3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

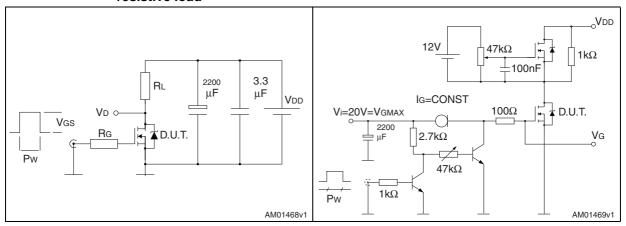


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

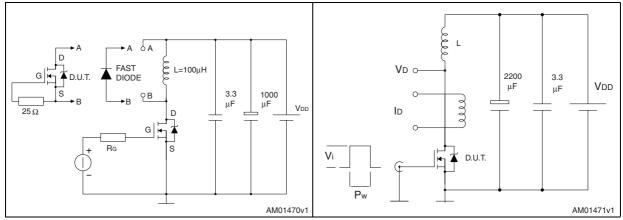
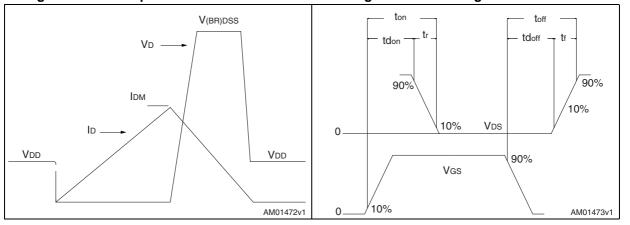


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



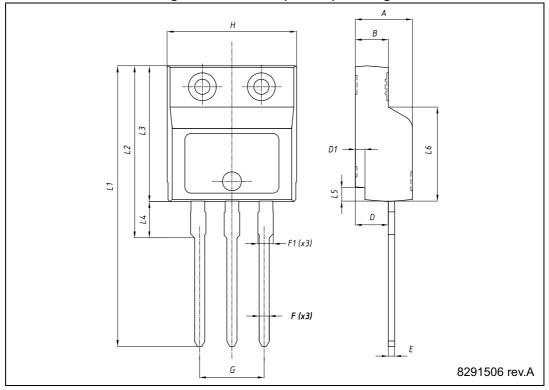
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

Table 9. I²PAKFP (TO-281) mechanical data

Dim		mm				
Dim.	Min.	Тур.	Max.			
А	4.40		4.60			
В	2.50		2.70			
D	2.50		2.75			
D1	0.65		0.85			
E	0.45		0.70			
F	0.75		1.00			
F1			1.20			
G	4.95	-	5.20			
Н	10.00		10.40			
L1	21.00		23.00			
L2	13.20		14.10			
L3	10.55		10.85			
L4	2.70		3.20			
L5	0.85		1.25			
L6	7.30		7.50			

Figure 21. I²PAKFP (TO-281) drawing



Revision history STFI5N95K3

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
09-May-2013	1	First release

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